

Notice of References Cited	Application/Control No. 10/577,014		Applicant(s)/Patent Under Reexamination SANO, HISASHI	
	Examiner RANDOLPH CHU		Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,565,044	07-2009	Akahoshi et al.	385/16
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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